

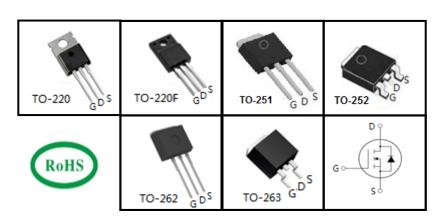
800V Super-Junction Power MOSFET

FEATURES

- $\bullet \quad \text{Very low FOM R}_{\text{DS(on)}} \times \text{Q}_{\text{g}} \\$
- 100% avalanche tested
- RoHS compliant

APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)



Device Marking and Package Information						
Device	TPP80R1K5C	TPA80R1K5C	TPU80R1K5C	TPD80R1K5C	TPC80R1K5C	TPB80R1K5C
Package	TO-220	TO-220F	TO-251	TO-252	TO-262	TO-263
Marking	80R1K5C	80R1K5C	80R1K5C	80R1K5C	80R1K5C	80R1K5C

Absolute Maximum Ratings $T_C = 25^{\circ}C$, unless otherwise noted					
		Value			
Parameter	Symbol	TO-220, TO-251, TO-252 TO-262, TO-263	TO-220F	Unit	
Drain-Source Voltage (V _{GS} = 0V)	V_{DSS}	800		V	
Continuous Drain Current	I _D	4		Α	
Pulsed Drain Current (note1)	I _{DM}	12		А	
Gate-Source Voltage	V _{GSS}	±30		V	
Single Pulse Avalanche Energy (note2)	E _{AS}	82.5		mJ	
Avalanche Current (note1)	I _{AR}	1.0		Α	
Repetitive Avalanche Energy (note1)	E _{AR}	0.15		mJ	
Power Dissipation (T _C = 25°C)	P _D	37 25		W	
Operating Junction and Storage Temperature Range	T _J , T _{stg}	-55~+150		°C	

Thermal Resistance						
		Value				
Parameter	Symbol	TO-220, TO-251, TO-252 TO-262, TO-263	TO-220F	Unit		
Thermal Resistance, Junction-to-Case	R _{thJC}	2.6	5.0	00.004		
Thermal Resistance, Junction-to-Ambient	R _{thJA}	62	80	°C/W		

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TPP80R1K5C, TPA80R1K50C, TPU80R1K5C, TPD80R1K5C, TPC80R1K5C, TPB80R1K5C

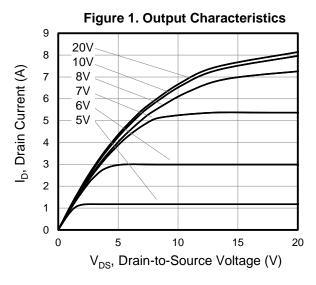
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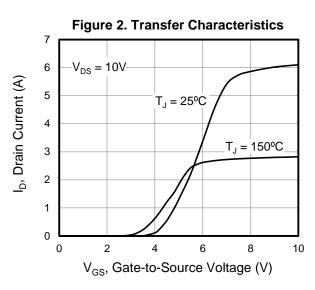
Paramatan.	0	To at O and distington	Value				
Parameter	Symbol Test Conditions		Min.	Тур.	Max.	Unit	
Static		•					
Drain-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0V, I_D = 250\mu A$	800			V	
Zoro Coto Voltogo Drain Current	I_{DSS} $V_{DS} = 800V, V_{GS} = 0V, T_{J} = 25^{\circ}C$ $V_{DS} = 800V, V_{GS} = 0V, T_{J} = 150^{\circ}C$			1			
Zero Gate Voltage Drain Current		$V_{DS} = 800V, V_{GS} = 0V, T_{J} = 150^{\circ}C$			100	μA	
Gate-Source Leakage	I_{GSS}	$V_{GS} = \pm 30V$			±100	nA	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.5		4.5	V	
Drain-Source On-Resistance (Note3)	R _{DS(on)}	V _{GS} = 10V, I _D = 2A		1.2	1.5	Ω	
Forward Transconductance (Note3)	g _{fs}	$V_{DS} = 10V, I_{D} = 2A$		3.5		S	
Dynamic							
Input Capacitance	C _{iss}	V - 0V		475		pF	
Output Capacitance	C _{oss}	$V_{GS} = 0V,$ $V_{DS} = 50V,$		24			
Reverse Transfer Capacitance	C _{rss}	f = 1.0MHz		3			
Total Gate Charge	Q_g			12		nC	
Gate-Source Charge	Q_{gs}	$V_{DD} = 640 \text{V}, I_{D} = 4 \text{A}, $ $V_{GS} = 10 \text{V}$		2.5			
Gate-Drain Charge	Q_{gd}			4			
Turn-on Delay Time	t _{d(on)}			40			
Turn-on Rise Time	t _r	$V_{DD} = 400V, I_{D} = 4A,$		26			
Turn-off Delay Time	t _{d(off)}	$R_G = 25\Omega$		95		ns	
Turn-off Fall Time	t _f			18			
Drain-Source Body Diode Characteris	stics						
Continuous Body Diode Current	I _S	T 0500			5	^	
Pulsed Diode Forward Current	I _{SM}	T _C = 25°C			15	Α	
Body Diode Voltage	V _{SD}	$T_J = 25^{\circ}C$, $I_{SD} = 4A$, $V_{GS} = 0V$		0.9	1.2	V	
Reverse Recovery Time	t _{rr}			226		ns	
Reverse Recovery Charge	Q _{rr}	$V_R = 400V, I_F = I_S,$ $di_F/dt = 100A/\mu s$		1.3		μC	
Peak Reverse Recovery Current	I _{rrm}	αι _τ , αι = 100/ 1 μυ		9.9		Α	

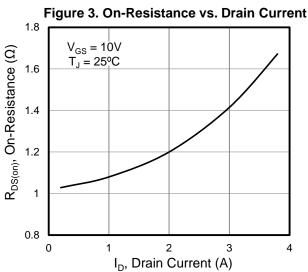
Notes

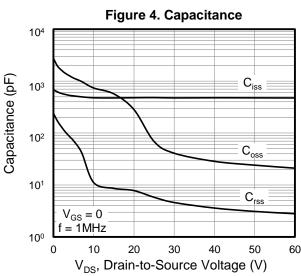
- 1. Repetitive Rating: Pulse Width limited by maximum junction temperature
- 2. I_{AS} = 1.0A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25 $^{\circ}$ C
- 3. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 1%

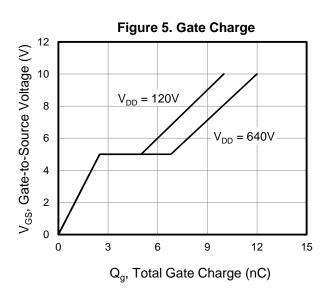
Typical Characteristics $T_J = 25^{\circ}C$, unless otherwise noted

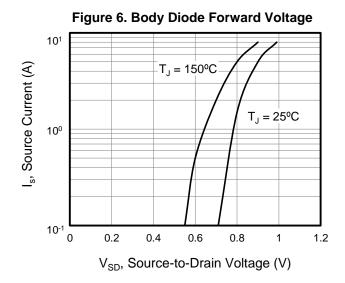










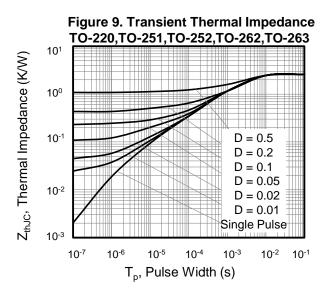




Typical Characteristics $T_J = 25^{\circ}\text{C}$, unless otherwise noted

Figure 7. On-Resistance vs. **Junction Temperature** 3 $V_{GS} = 10V$ $I_D = 2A$ 2.5 R_{DS(on)}, (Normalized) 2 1.5 0.5 0 -100 -50 50 100 150 200 T_J, Junction Temperature (°C)

Figure 8. Threshold Voltage vs. **Junction Temperature** 0.6 $I_{D} = 250 \mu A$ 0.4 0.2 V_{GS(th)}, (Variance) 0 -0.2 -0.4 -0.6 -0.8 -1 -1.2 -100 -50 100 150 200 T_J, Junction Temperature (°C)



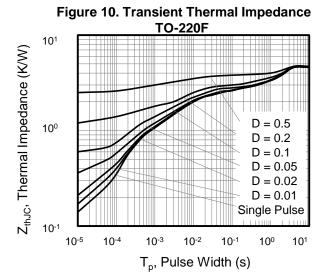




Figure A: Gate Charge Test Circuit and Waveform

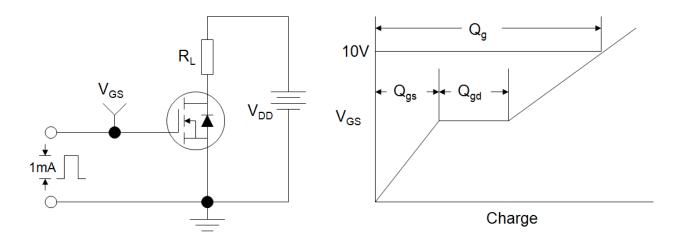


Figure B: Resistive Switching Test Circuit and Waveform

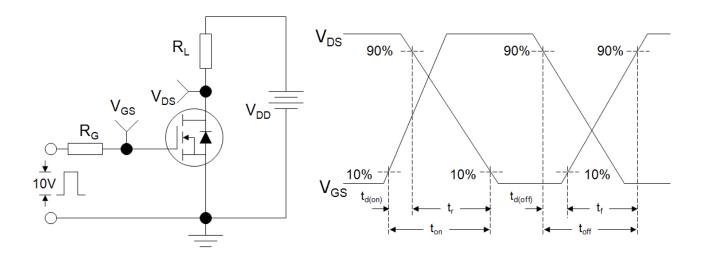
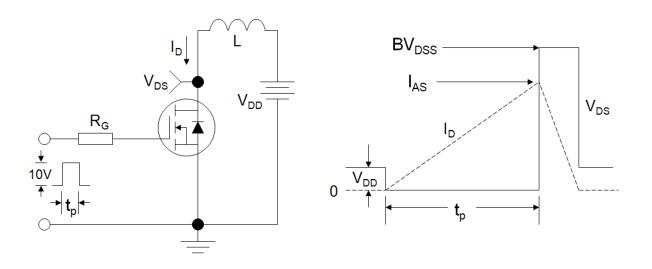
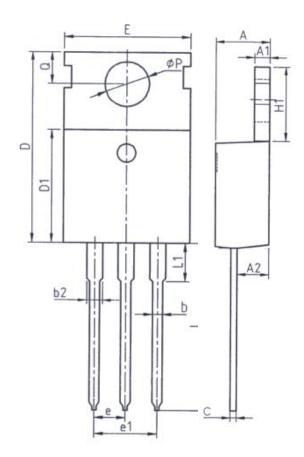


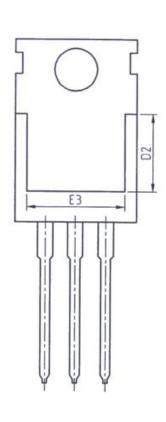
Figure C: Unclamped Inductive Switching Test Circuit and Waveform



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TO-220

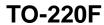


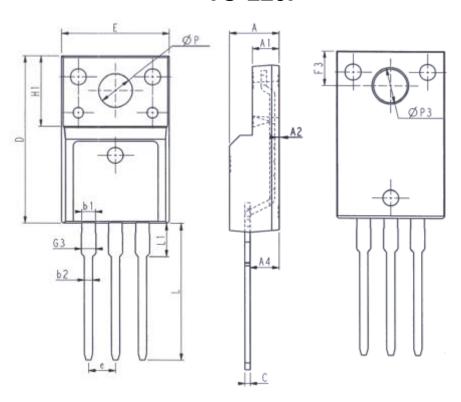


Unit: mm					
Symbol	Min.	Max.			
Α	4. 37	4. 77			
A1	1. 25	1. 45			
A2	2. 20	2. 60			
b	0. 70	0. 95			
b2	1. 17	1. 47			
С	0. 40	0. 65			
D	15. 10	16. 10			
D1	8. 80	9. 40			
D2	5. 50	_			

Unit: mm					
Symbol	Min.	Max.			
E	9. 70	10. 30			
E3	7. 00 -				
е	2. 54BSC				
e1	5. 08BSC				
H1	6. 25	6. 85			
L	12. 75	13. 80			
L1	-	3. 40			
Р	3. 40	3. 80			
Q	2. 60	3. 00			



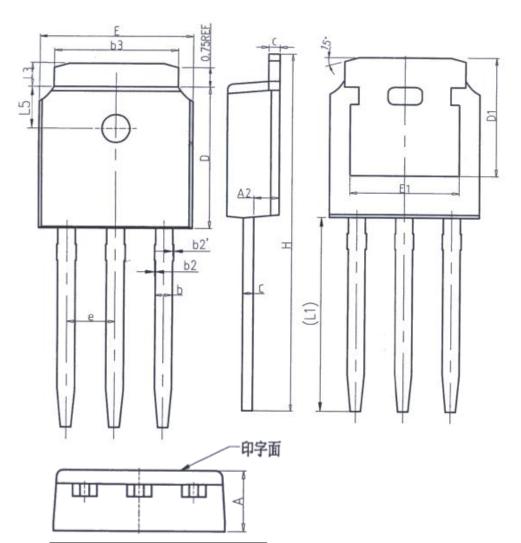




Unit: mm			l	Jnit: mn	n
Symbol	Min.	Max.	Symbol	Min.	Max.
E	9.96	10.36	L	12. 68	13. 28
Α	4. 50	4. 90	L1	2. 93	3. 13
A1	2. 34	2. 74	Р	3. 03	3. 38
A2	0. 30	0. 60	Р3	3. 15	3. 65
A4	2. 56	2. 96	F3	3. 15	3. 45
С	0.40	0. 65	G3	1. 25	1. 55
D	15. 57	16. 17	b1	1. 18	1. 43
H1	6. 70REF		b2	0. 70	0. 95
6	2 54BSC				



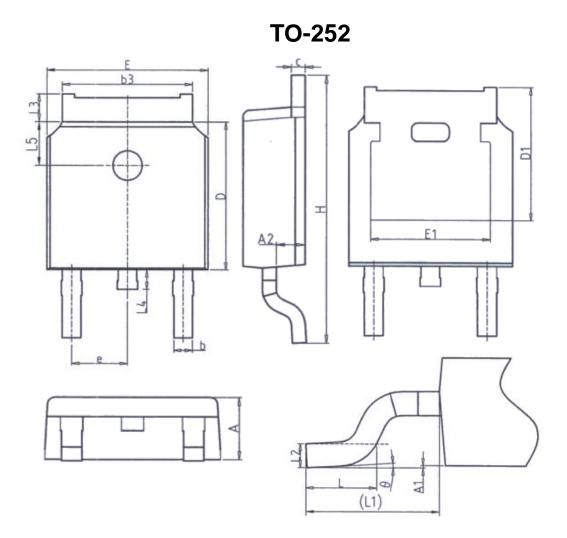
TO-251



Unit: mm					
Symbol	Min.	Max.			
Α	2. 20	2. 40			
A2	0. 97	1. 17			
b	0. 68	0.90			
b2	0.00	0.10			
b2′	0.00	0.10			
b3	5. 20	5. 50			
С	0. 43	0. 63			
D	5. 98	6. 22			

Unit: mm					
Symbol	Min.	Max.			
D1	5. 30REF				
E	6. 40	6. 80			
E1	4. 63	-			
е	2. 286BSC				
Н	16. 22	16. 82			
L1	9. 15	9. 65			
L3	0. 88	1. 28			
L5	1. 65	1. 95			

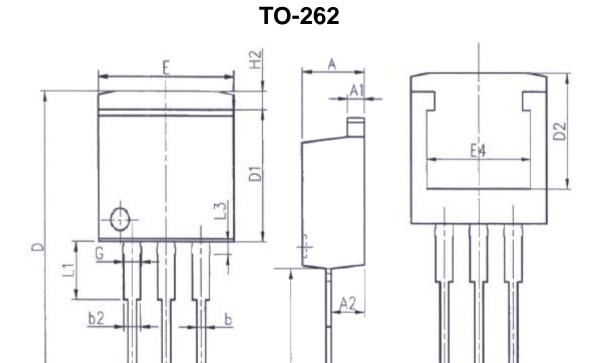




Unit: mm						
Symbol	Min.	Max.				
Α	2. 20	2. 40				
A1	0.00	0. 20				
A2	0. 97	1. 17				
b	0. 68	0. 90				
b3	5. 20	5. 50				
С	0. 43	0. 63				
D	5. 98	6. 22				
D1	5. 30REF					
E	6. 40	6. 80				
E1	4. 63	_				

Unit: mm					
Symbol	Min.	Max.			
е	2. 286BSC				
Н	9. 40	10.50			
L	1. 38	1. 75			
L1	2. 90REF				
L2	0. 51	IBSC			
L3	0.88	1. 28			
L4	- 1.00				
L5	1. 65 1. 95				
θ	0°	8°			



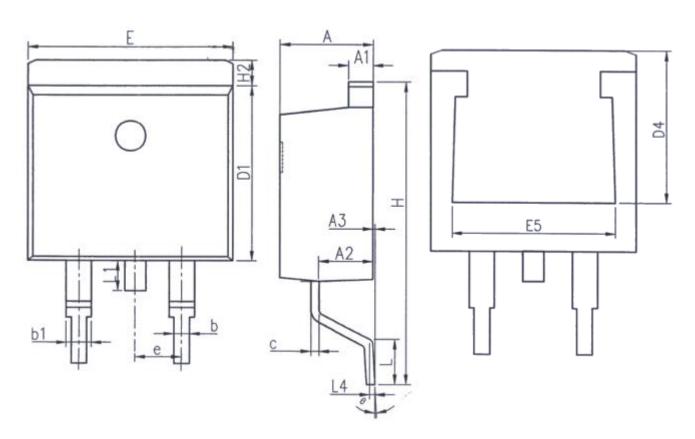


Unit: mm					
Symbol	Min.	Max.			
Α	4. 37	4. 77			
A1	1. 22	1. 42			
A2	2. 47	2. 87			
b	0. 70	0. 97			
b2	1. 17	1. 42			
С	0. 28	0.53			
D	23. 20	24. 02			
D1	8. 38	8. 90			
D2	6. 00	_			

Unit: mm			
Symbol	Min.	Max.	
E	9. 90	10. 39	
E4	7. 30	_	
е	2. 54BSC		
G	1. 25	1.50	
H2	-	1. 31	
L	13. 34	14. 10	
L1	3. 30	4. 06	
L3	0. 95	1. 15	



TO-263



Unit: mm			
Symbol	Min.	Max.	
Α	4. 37	4. 77	
A 1	1. 22	1. 42	
A2	2. 49	2. 89	
A3	0. 00	0. 25	
b	0. 70	0. 96	
b1	1. 17	1. 47	
С	0. 30	0. 53	
D1	8. 50	8. 90	
D4	6. 60	_	

Unit: mm			
Symbol	Min.	Max.	
E	9.86	10.36	
E 5	7. 06	-	
e	2. 54BSC		
Н	14. 70	15. 50	
H2	1. 07	1. 47	
L	2.00	2. 60	
L1	1. 40	1. 70	
L4	0. 25BSC		
θ	0°	9°	





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